

Notice of References Cited	Application/Control No. 10/672,225		Applicant(s)/Patent Under Reexamination ALFERIEV ET AL.	
	Examiner David J. Venci		Art Unit 1641	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,020,457	02-2000	Klimash et al.	528/373
	B	US-			
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO 96/07676	03-1996	WIPO	EKAGEN CORP.	C08F 8/34
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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